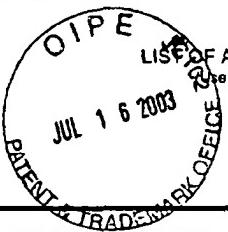


Form PTO-1489E  <b>LIST OF ART CITED BY APPLICANT</b> <small>(use several sheets if necessary)</small>				ATTY. DOCKET NO. MISS-003	SERIAL NO. 09/788,878	
				APPLICANT Graham Wolstenholme		
				FILING DATE January 23, 2001	GROUP 2812	
U.S. PATENT DOCUMENTS						
*Examiner Initials	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
RB	8,235,582	05/2001	Chen	438	257	
RB	8,687,573	11/1999	Mitsko	711	156	
RB	8,232,181	05/2001	Lee	438	257	
RB	8,512,504	04/1998	Wolstenholme, et al.	437	43	
RB	8,337,244 B1	01/2002	Prall et al.	438	257	
RB	8,406,968 B2	06/2002	Prall et al.	438	268	
AO						
AH						
AI						
AJ						
AK						
AL						
FOREIGN PATENT DOCUMENTS						
	Document Number	Date	Country	Class	Subclass	Translation
AL						Yes
AM						No
AN						
AO						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)						
	AP					
	AQ					
	AR					
EXAMINER	<i>Richard A R</i>			DATE CONSIDERED	8/19/03	TECHNOLOGY CENTER 2800

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. MI55-003		SERIAL NO. 09/768,878	
 LIST OF ART CITED BY APPLICANT (use several sheets if necessary)					APPLICANT: Graham Wolstenholme			
		FILING DATE January 23, 2001		GROUP 2812				
<b>U.S. PATENT DOCUMENTS</b>								
*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
<i>AB</i>	AA	4,698,900	10/13/87	Esquivel	—	—		
	AB	5,960,276	09/28/99	Liaw et al.	—	—		
	AC	6,103,574	08/15/00	Iwasaki	—	—		
	AD	6,245,639 B1	06/12/01	Tsai et al.	—	—		
	AE	6,277,693 B1	08/21/01	Chen	—	—		
<i>AB</i>	AF	6,306,737 B1	10/23/01	Mehrad et al.	—	—		
<i>AB</i>	AG	09/650,711		Hurley et al.			08/29/00	
	AH	10/091,630 20030034511 2/2003		Hurley et al.			09/30/02	
<i>Wrong ref. #</i>	AI	10/357,064		Hurley et al.			02/28/03	
<b>FOREIGN PATENT DOCUMENTS</b>								
		Document Number	Date	Country	Class	Subclass	Translation	
	AJ						Yes	No
	AK							
	AL							
<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AM							
	AN							
	AO							
<i>Richardson</i>	EXAMINER	DATE CONSIDERED	<i>2/19/03</i>					RECEIVED JUL 23 2003 TECHNOLOGY CENTER 2800
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. MI55-003		SERIAL NO. 09/768,878	
 LIST OF ART CITED BY APPLICANT (use several sheets if necessary)					APPLICANT: Graham Wolstenholme			
					FILING DATE January 23, 2001		GROUP 2812	
<b>U.S. PATENT DOCUMENTS</b>								
*Examiner's Initials		Document Number	Date	Name		Class	Subclass	Filing Date If Appropriate
RB	AA	2002/0038884 A1	04/04/02	Shirota et al.		—	—	
RB	AB	2002/0045303 A1	04/18/02	Lee		—	—	
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
<b>FOREIGN PATENT DOCUMENTS</b>								
		Document Number	Date	Country		Class	Subclass	Translation
	AJ							Yes
	AK							No
	AL							
<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AM							RECEIVED
	AN							JUL 23 2003
	AO							TECHNOLOGY CENTER 2800
<b>EXAMINER</b> <i>[Signature]</i>	DATE CONSIDERED <i>2/19/03</i>							
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